

HCS80R250T

800V N-Channel Super Junction MOSFET

Description

- ❑ Very Low FOM ($R_{DS(on)} \times Q_g$)
- ❑ Extremely low switching loss
- ❑ Excellent stability and uniformity
- ❑ 100% Avalanche Tested

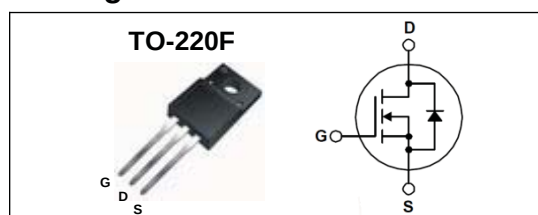
Features

- ❑ Switch Mode Power Supply (SMPS)
- ❑ Uninterruptible Power Supply (UPS)
- ❑ Power Factor Correction (PFC)
- ❑ Motor Control & LED Lighting Power
- ❑ DC-DC Converters

Key Parameters

Parameter	Value	Unit
$BV_{DSS} @ T_{J,max}$	850	V
I_D	18	A
$R_{DS(on), max}$	0.25	Ω
Q_g, Typ	58	nC

Package & Internal Circuit



Absolute Maximum Ratings $T_C=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Value	Units
V_{DSS}	Drain-Source Voltage	800	V
V_{GS}	Gate-Source Voltage	± 30	V
I_D	Drain Current – Continuous ($T_C = 25^\circ\text{C}$)	18 *	A
	Drain Current – Continuous ($T_C = 100^\circ\text{C}$)	11*	A
I_{DM}	Drain Current – Pulsed (Note 1)	54 *	A
E_{AS}	Single Pulsed Avalanche Energy (Note 2)	280	mJ
I_{AR}	Avalanche Current (Note 1)	7.5	A
E_{AR}	Repetitive Avalanche Energy (Note 1)	0.5	mJ
dv/dt	MOSFET dv/dt ruggedness, $V_{DS}=0\dots 480\text{V}$	50	V/ns
dv/dt	Reverse diode dv/dt, $V_{DS}=0\dots 480\text{V}$, $I_{DS}\leq I_D$	15	V/ns
P_D	Power Dissipation ($T_C = 25^\circ\text{C}$)	34	W
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ\text{C}$

* Drain current limited by maximum junction temperature

Thermal Resistance Characteristics

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	--	3.67	$^\circ\text{C/W}$
$R_{\theta JA}$	Junction-to-Ambient	--	80	

Electrical Characteristics $T_J=25\text{ }^{\circ}\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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On Characteristics

V_{GS}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	2.5	--	4.5	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS} = 10\text{ V}, I_D = 9\text{ A}$	--	0.22	0.25	Ω

Off Characteristics

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	800	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}$	--	--	1	μA
		$V_{DS} = 800\text{ V}, T_J = 125\text{ }^{\circ}\text{C}$	--	--	100	μA
I_{GSS}	Gate-Body Leakage Current	$V_{GS} = \pm 30\text{ V}, V_{DS} = 0\text{ V}$	--	--	± 100	nA

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS} = 50\text{ V}, V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz}$	--	2550	--	pF
C_{oss}	Output Capacitance		--	260	--	pF
C_{rss}	Reverse Transfer Capacitance		--	15	--	pF

Switching Characteristics

$t_{d(on)}$	Turn-On Time	$V_{DS} = 400\text{ V}, I_D = 18\text{ A},$ $R_G = 25\text{ }\Omega$	--	64	--	ns
t_r	Turn-On Rise Time		--	28	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	180	--	ns
t_f	Turn-Off Fall Time		--	19	--	ns
Q_g	Total Gate Charge	$V_{DS} = 640\text{ V}, I_D = 18\text{ A}$ $V_{GS} = 10\text{ V}$	--	58	--	nC
Q_{gs}	Gate-Source Charge		--	15	--	nC
Q_{gd}	Gate-Drain Charge		--	23	--	nC

Source-Drain Diode Maximum Ratings and Characteristics

I _S	Continuous Source-Drain Diode Forward Current		--	--	18	A
I _{SM}	Pulsed Source-Drain Diode Forward Current		--	--	54	
V _{SD}	Source-Drain Diode Forward Voltage	I _S = 18 A, V _{GS} = 0 V	--	--	1.3	V
trr	Reverse Recovery Time	I _S = 18 A, V _{DD} = 400 V di _F /dt = 100 A/μs	--	400	--	ns
Qrr	Reverse Recovery Charge		--	4	--	μC

Notes ;

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. $I_{AS}=7.5\text{ A}, V_{DD}=50\text{ V}, R_G=25\Omega$, Starting $T_J=25^{\circ}\text{C}$
3. $I_{SD}\leq I_D$, $di/dt \leq 200\text{ A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25\text{ }^{\circ}\text{C}$
4. Pulse Test : Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$
5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Characteristics

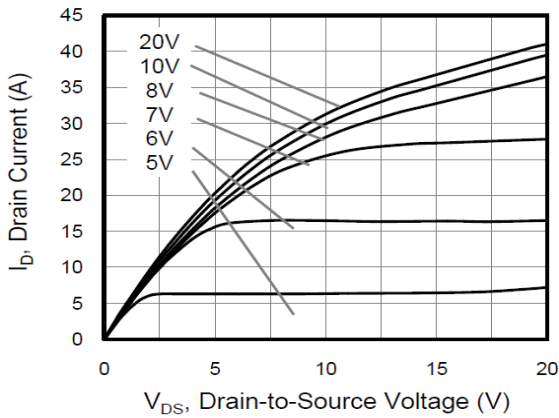


Figure 1. On Region Characteristics

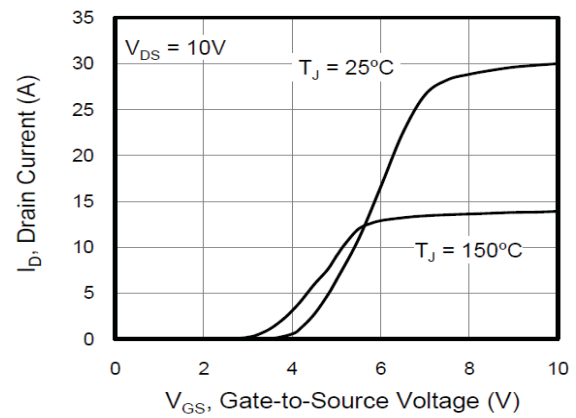


Figure 2. Transfer Characteristics

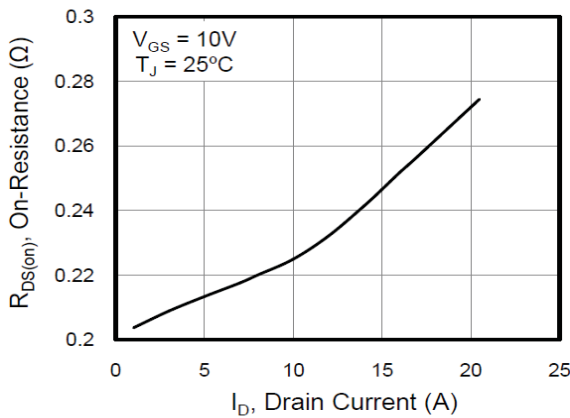


Figure 3. On Resistance Variation vs Drain Current and Gate Voltage

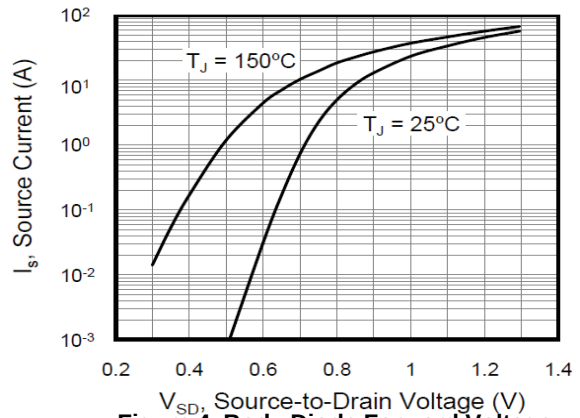


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

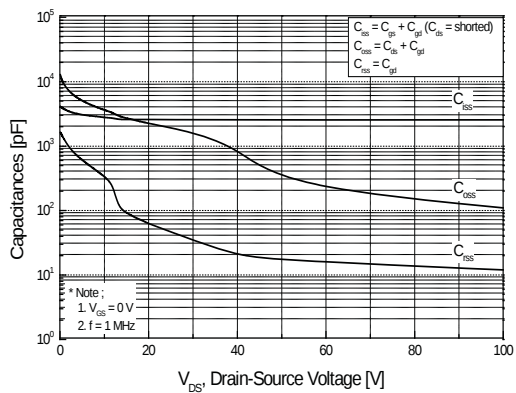


Figure 5. Capacitance Characteristics

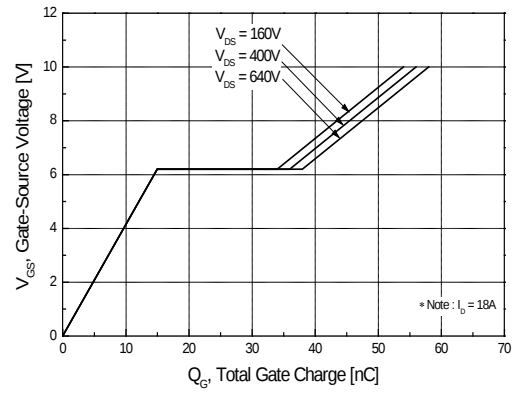


Figure 6. Gate Charge Characteristics

Typical Characteristics (continued)

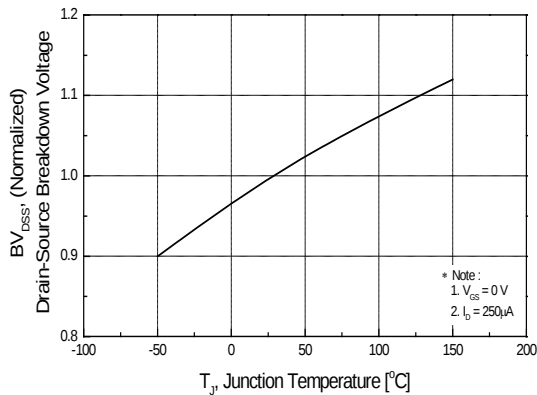


Figure 7. Breakdown Voltage Variation vs Temperature

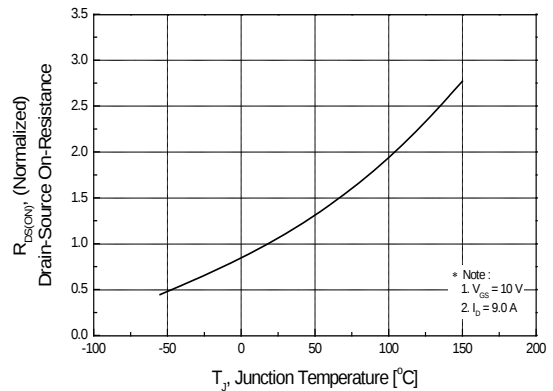


Figure 8. On-Resistance Variation vs Temperature

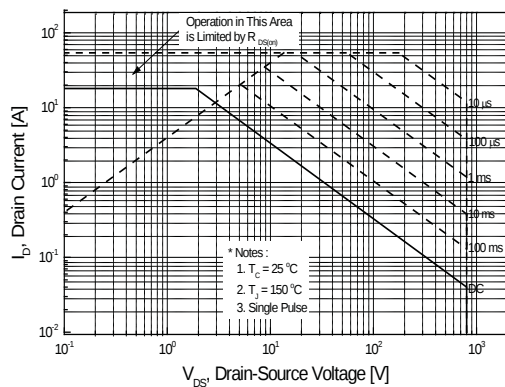


Figure 9. Maximum Safe Operating Area

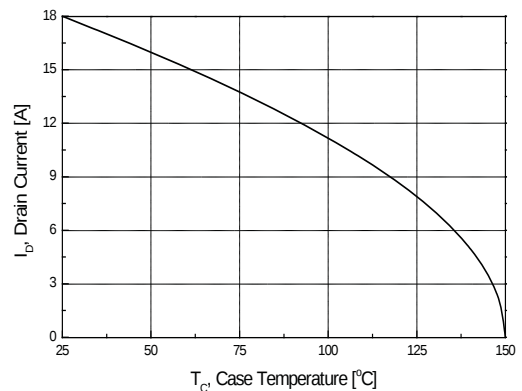


Figure 10. Maximum Drain Current vs Case Temperature

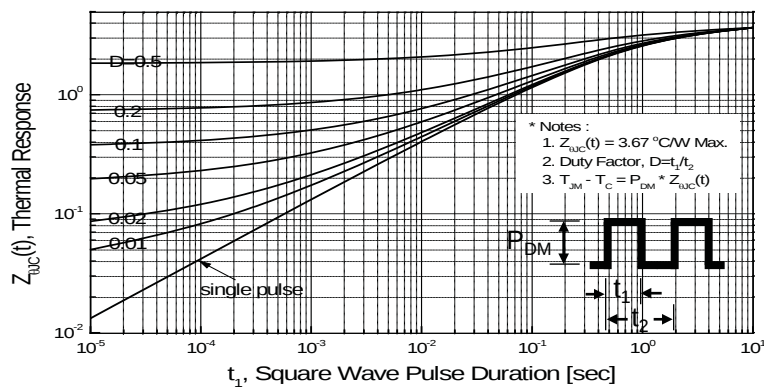


Figure 11. Transient Thermal Response Curve

Fig 12. Gate Charge Test Circuit & Waveform

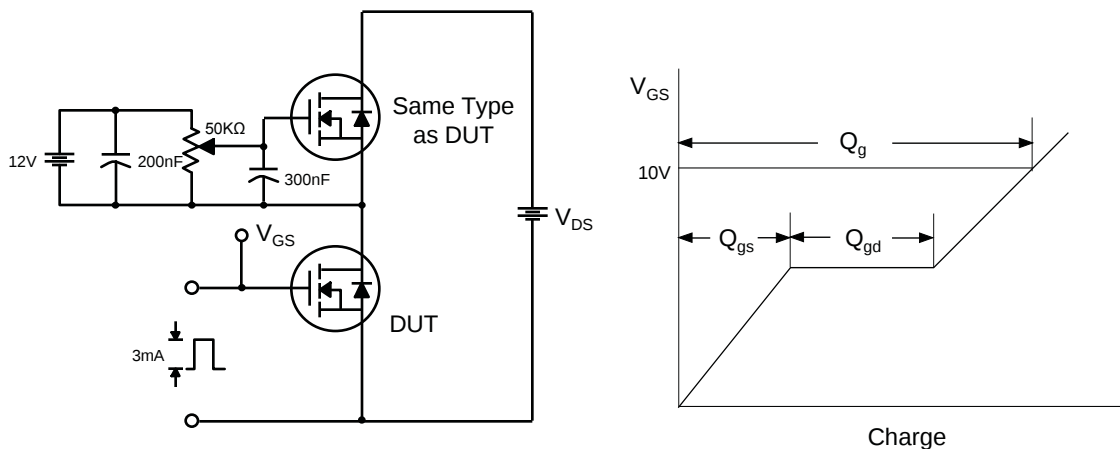


Fig 13. Resistive Switching Test Circuit & Waveforms

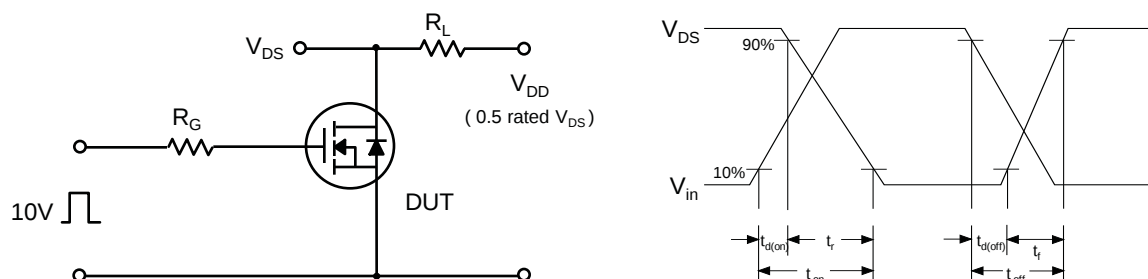


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms

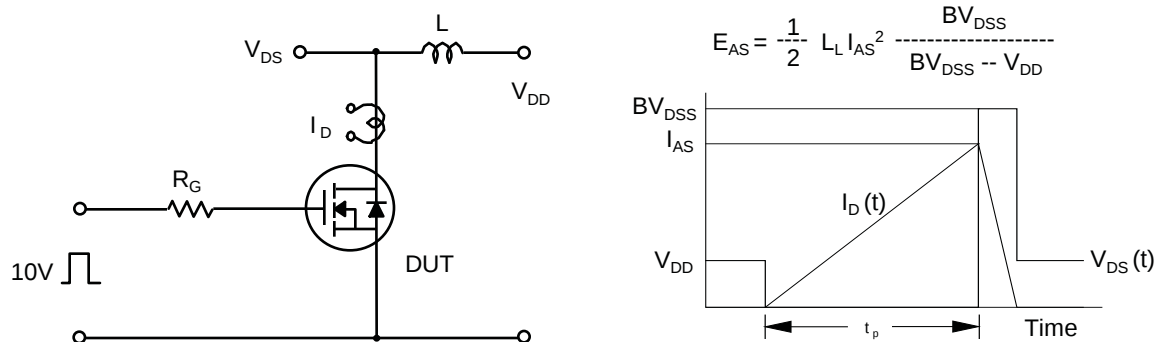
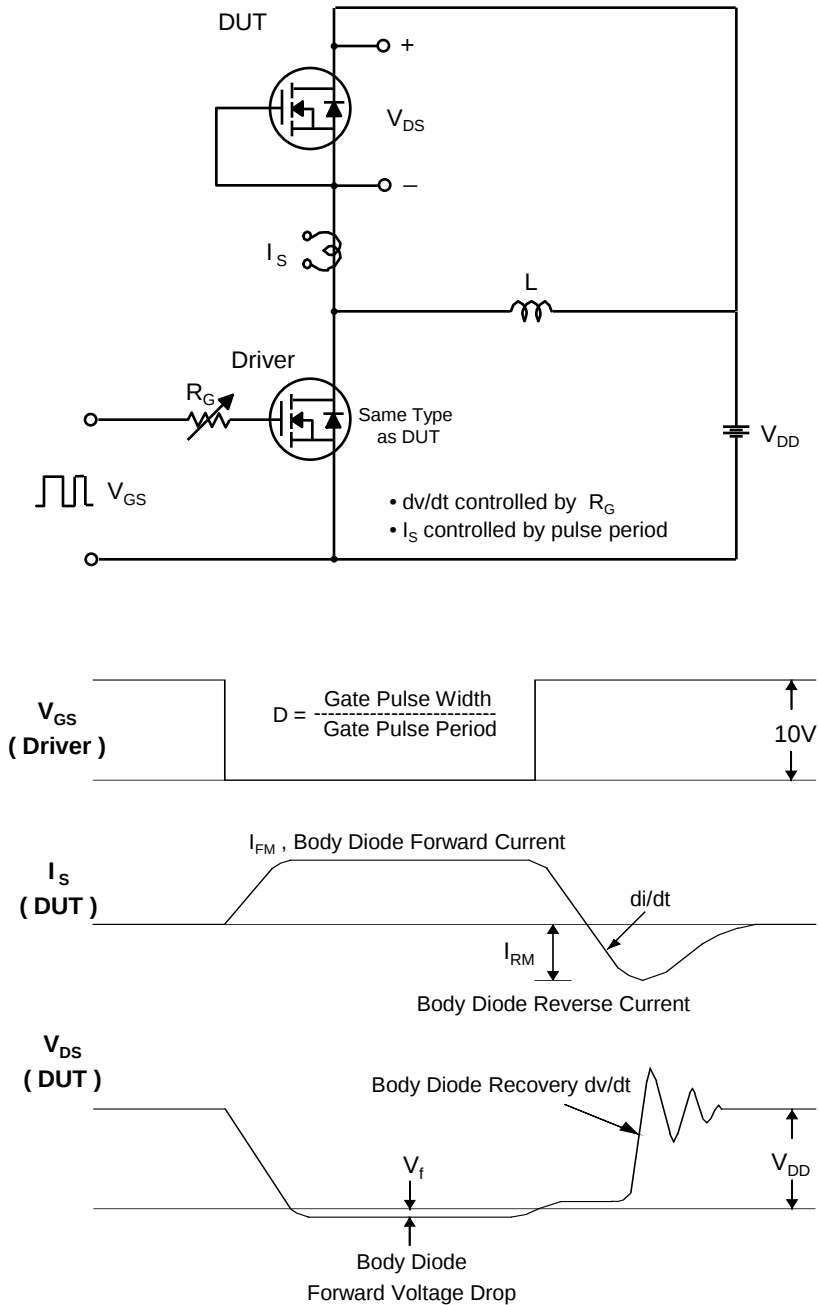
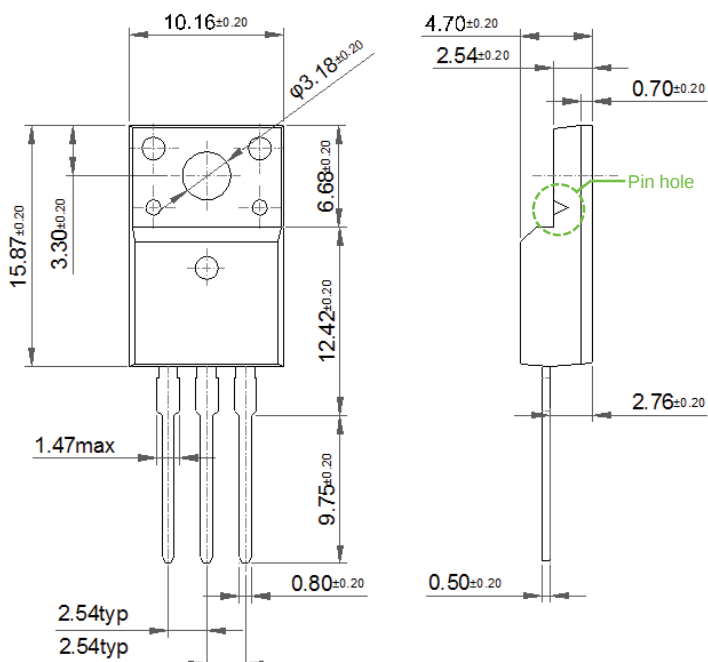


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



Package Dimension

TO-220F



TO-220F-FM

